

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO. : 6,872,951 B2
DATED : March 29, 2005
INVENTOR(S) : Takayuki Yagi et al.

Page 1 of 2

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Title page.

Item [56], **References Cited, OTHER PUBLICATIONS**, "Sub-Nanometer" reference, "Minature" should read -- Miniature --.

Column 1.

Line 35, "beams" should read -- beam system --.

Column 2.

Line 21, "suffers" should read -- suffers from --.

Lines 25 and 46, "destruct" should read -- destroy --.

Line 52, "arts." should read -- art. --.

Column 3.

Line 11, "includes" should read -- include --.

Line 50, "dice or" should read -- a die or --.

Column 9.

Line 56, "arrays" should read -- array --.

Column 10.

Line 67, after "excellent", the right margin should be closed up.

Column 11.

Line 17, after "1010", the right margin should be closed up.

Column 12.

Line 30, after "factory.", the right margin should be closed up.

Line 49, "a trouble" should read -- trouble --.

Column 13.

Line 11, "and.," should read -- and --.

Line 55, "a trouble" should read -- trouble --.

Column 15.

Line 4, "number" should read -- member --.

Line 11, "system" should read -- array --.

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Column 16.

Line 28, "arrange" should read -- arranged --.

Column 17.

Line 9, "electrodes" should read -- electrode --.

Line 20, "intermediated" should read -- intermediate --.

Line 24, "optical" should read -- optical system array --.

Line 25, "image" should read -- images --.

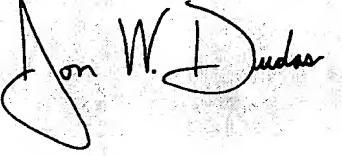
Column 18.

Line 20, "intermediated" should read -- intermediate --.

Line 23, "structure" should read -- structures --.

Signed and Sealed this

Eighth Day of November, 2005



JON W. DUDAS
Director of the United States Patent and Trademark Office